

Search Notes

Application/Control No.

10/537,616

Examiner

Y. Lee

Applicant(s)/Patent under
Reexamination

BARRAU ET AL.

Art Unit

2621

SEARCHED

Class	Subclass	Date	Examiner
375	240.01 240.11 ** 240.16 240.19	9/21/2009	YL
	240.29		
H04N	7/12		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR